

74AC821 • 74ACT821

10-Bit D-Type Flip-Flop with 3-STATE Outputs

General Description

The AC/ACT821 is a 10-bit D-type flip-flop with 3-STATE outputs arranged in a broadside pinout.

Features

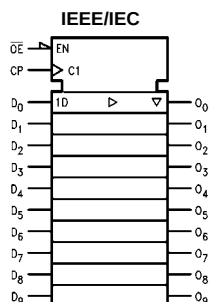
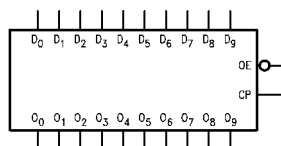
- 3-STATE outputs for bus interfacing
- Noninverting outputs
- Outputs source/sink 24 mA
- TTL compatible inputs

Ordering Code:

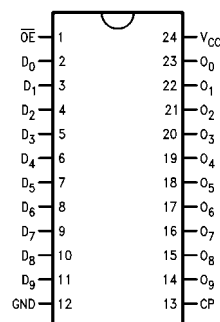
Order Number	Package Number	Package Description
74AC821SC	M24B	24-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide
74AC821SPC	N24C	24-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide
74ACT821SC	M24B	24-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide
74ACT821MTC	MTC24	24-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide
74ACT821SPC	N24C	24-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide

Device also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering code. (SPC not available in Tape and Reel.)

Logic Symbols



Connection Diagram



Pin Descriptions

Pin Names	Description
D ₀ –D ₉	Data Inputs
Q ₀ –Q ₉	Data Outputs
$\overline{OE}$	Output Enable Input
CP	Clock Input

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Functional Description

The AC/ACT821 consists of ten D-type edge-triggered flip-flops. The buffered Clock (CP) and buffered Output Enable ($\overline{OE}$) are common to all flip-flops. The flip-flops will store the state of their individual D inputs that meet the setup and hold time requirements on the LOW-to-HIGH CP transition.

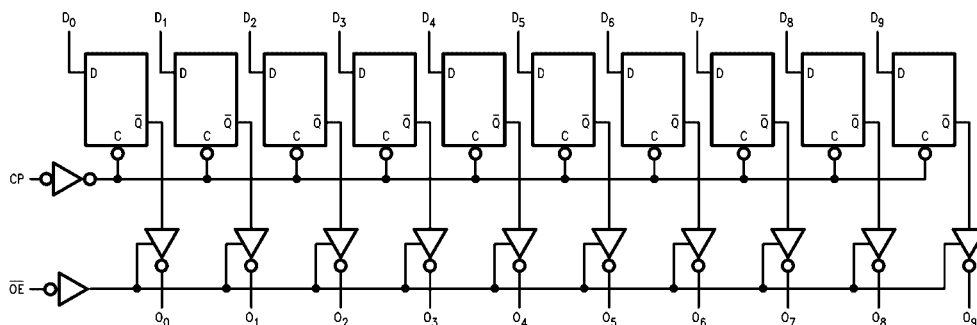
With $\overline{OE}$ LOW the contents of the flip-flops are available at the outputs. When $\overline{OE}$ is HIGH the outputs go to the high impedance state. Operation of the $\overline{OE}$ input does not affect the state of the flip-flops.

Function Table

Inputs			Internal	Outputs	Function
$\overline{OE}$	CP	D	Q	O	
H	⎵	L	L	Z	High Z
H	⎵	H	H	Z	High Z
L	⎵	L	L	L	Load
L	⎵	H	H	H	Load

H = HIGH Voltage Level
 L = LOW Voltage Level
 Z = HIGH Impedance
 ⎵ = LOW-to-HIGH Clock Transition

Logic Diagram



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

Absolute Maximum Ratings(Note 1)

Supply Voltage (V_{CC})	– 0.5V to + 7.0V
DC Input Diode Current (I_{IK})	
$V_I = -0.5V$	– 20 mA
$V_I = V_{CC} + 0.5V$	+ 20 mA
DC Input Voltage (V_I)	– 0.5V to $V_{CC} + 0.5V$
DC Output Diode Current (I_{OK})	
$V_O = -0.5V$	– 20 mA
$V_O = V_{CC} + 0.5V$	+ 20 mA
DC Output Voltage (V_O)	– 0.5V to $V_{CC} + 0.5V$
DC Output Source or Sink Current (I_O)	± 50 mA
DC V_{CC} or Ground Current per Output Pin (I_{CC} or I_{GND})	± 50 mA
Storage Temperature (T_{STG})	– 65°C to + 150°C
Junction Temperature (T_J)	
PDIP	140°C

Recommended Operating Conditions

Supply Voltage (V_{CC})	
AC	2.0V to 6.0V
ACT	4.5V to 5.5V
Input Voltage (V_I)	0V to V_{CC}
Output Voltage (V_O)	0V to V_{CC}
Operating Temperature (T_A)	– 40°C to + 85°C
Minimum Input Edge Rate ($\Delta V/\Delta t$)	
AC Devices	
V_{IN} from 30% to 70% of V_{CC}	
V_{CC} @ 3.3V, 4.5V, 5.5V	125 mV/ns
Minimum Input Edge Rate ($\Delta V/\Delta t$)	
ACT Devices	
V_{IN} from 0.8V to 2.0V	
V_{CC} @ 4.5V, 5.5V	125 mV/ns

Note 1: Absolute maximum ratings are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. Fairchild does not recommend operation of FACT™ circuits outside databook specifications.

DC Electrical Characteristics for AC

Symbol	Parameter	V _{CC} (V)	T _A = +25°C		T _A = −40°C to +85°C		Units	Conditions
			Typ	Guaranteed Limits				
V _{IH}	Minimum HIGH Level Input Voltage	3.0	1.5	2.1	2.1		V	V _{OUT} = 0.1V or V _{CC} − 0.1V
		4.5	2.25	3.15	3.15			
		5.5	2.75	3.85	3.85			
V _{IL}	Maximum LOW Level Input Voltage	3.0	1.5	0.9	0.9		V	V _{OUT} = 0.1V or V _{CC} − 0.1V
		4.5	2.25	1.35	1.35			
		5.5	2.75	1.65	1.65			
V _{OH}	Minimum HIGH Level Output Voltage	3.0	2.99	2.9	2.9		V	I _{OUT} = − 50 μA
		4.5	4.49	4.4	4.4			
		5.5	5.49	5.4	5.4			
		3.0		2.56	2.46		V	V _{IN} = V _{IL} or V _{IH} I _{OH} = − 12 mA I _{OH} = − 24 mA I _{OH} = − 24 mA (Note 2)
		4.5		3.86	3.76			
		5.5		4.86	4.76			
V _{OL}	Maximum LOW Level Output Voltage	3.0	0.002	0.1	0.1		V	I _{OUT} = 50 μA
		4.5	0.001	0.1	0.1			
		5.5	0.001	0.1	0.1			
		3.0		0.36	0.44		V	V _{IN} = V _{IL} or V _{IH} I _{OL} = 12 mA I _{OL} = 24 mA I _{OL} = 24 mA (Note 2)
		4.5		0.36	0.44			
		5.5		0.36	0.44			
I _{IN} (Note 4)	Maximum Input Leakage Current	5.5		± 0.1	± 1.0		μA	V _I = V _{CC} , GND
I _{OZ}	Maximum 3-STATE Current	5.5		±0.5	±5.0		μA	V _I (OE) = V _{IL} , V _{IH} V _I = V _{CC} , GND V _O = V _{CC} , GND
I _{OLD}	Minimum Dynamic	5.5			75		mA	V _{OLD} = 1.65V Max
I _{OHD}	Output Current (Note 3)	5.5			−75		mA	V _{OHD} = 3.85V Min
I _{CC} (Note 4)	Maximum Quiescent Supply Current	5.5		8.0	80.0		μA	V _{IN} = V _{CC} or GND

Note 2: All outputs loaded; thresholds on input associated with output under test.

Note 3: Maximum test duration 2.0 ms, one output loaded at a time.

Note 4: I_{IN} and I_{CC} @ 3.0V are guaranteed to be less than or equal to the respective limit @ 5.5V V_{CC} .

DC Electrical Characteristics for ACT

Symbol	Parameter	V _{CC} (V)	T _A = +25°C		T _A = -40°C to +85°C		Units	Conditions
			Typ	Guaranteed Limits				
V _{IH}	Minimum HIGH Level Input Voltage	4.5	1.5	2.0	2.0		V	V _{OUT} = 0.1V or V _{CC} - 0.1V
		5.5	1.5	2.0	2.0			
V _{IL}	Maximum LOW Level Input Voltage	4.5	1.5	0.8	0.8		V	V _{OUT} = 0.1V or V _{CC} - 0.1V
		5.5	1.5	0.8	0.8			
V _{OH}	Minimum HIGH Level Output Voltage	4.5	4.49	4.4	4.4		V	I _{OUT} = - 50 μA
		5.5	5.49	5.4	5.4			
		4.5		3.86	3.76		V	V _{IN} = V _{IL} or V _{IH} I _{OH} = - 24 mA I _{OH} = - 24 mA (Note 5)
		5.5		4.86	4.76			
V _{OL}	Maximum LOW Level Output Voltage	4.5	0.001	0.1	0.1		V	I _{OUT} = 50 μA
		5.5	0.001	0.1	0.1			
		4.5		0.36	0.44		V	V _{IN} = V _{IL} or V _{IH} I _{OL} = 24 mA I _{OL} = 24 mA (Note 5)
		5.5		0.36	0.44			
I _{IN} (Note 4)	Maximum Input Leakage Current	5.5		±0.1	±1.0		μA	V _I = V _{CC} , GND
I _{OZ}	Maximum 3-STATE Current	5.5		±0.5	±5.0		μA	V _I = V _{IL} , V _{IH} V _O = V _{CC} , GND
I _{CCT}	Maximum I _{CC} /Input	5.5	0.6		1.5		mA	V _I = V _{CC} - 2.1V
I _{OLD}	Minimum Dynamic	5.5			75		mA	V _{OLD} = 1.65V Max
I _{OHD}	Output Current (Note 6)	5.5			-75		mA	V _{OHD} = 3.85V Min
I _{CC}	Maximum Quiescent Supply Current	5.5		8.0	80.0		μA	V _{IN} = V _{CC} or GND

Note 5: All outputs loaded; thresholds on input associated with output under test.

Note 6: Maximum test duration 2.0 ms, one output loaded at a time.

AC Electrical Characteristics for AC

Symbol	Parameter	V _{CC} (V) (Note 7)	T _A = +25°C C _L = 50 pF			T _A = -40°C to +85°C C _L = 50 pF		Units
			Min	Typ	Max	Min	Max	
f _{MAX}	Maximum Clock Frequency	3.3 5.0	110 120	145 160		100 110		MHz
t _{PLH}	Propagation Delay CP to O _n	3.3 5.0	3.0 2.0	8.0 6.0	13.0 9.5	3.0 2.0	15.0 10.5	ns
t _{PHL}	Propagation Delay CP to O _n	3.3 5.0	3.0 2.0	8.0 5.5	13.0 9.5	3.0 2.0	15.0 10.5	ns
t _{PZH}	Output Enable Time OE to O _n	3.3 5.0	2.5 1.5	6.0 4.5	11.0 8.0	2.5 1.5	12.0 9.0	ns
t _{PZL}	Output Enable Time OE to O _n	3.3 5.0	2.5 1.5	6.5 5.0	11.0 8.0	2.5 1.5	12.0 9.0	ns
t _{PHZ}	Output Disable Time OE to O _n	3.3 5.0	2.5 1.5	6.5 5.0	10.5 8.0	2.5 1.5	11.0 8.5	ns
t _{PLZ}	Output Disable Time OE to O _n	3.3 5.0	2.5 1.5	6.0 4.5	10.5 8.0	2.5 1.5	11.0 8.5	ns

Note 7: Voltage Range 3.3 is 3.3V ± 0.3V
Voltage Range 5.0 is 5.0V ± 0.5V

AC Operating Requirements for AC

Symbol	Parameter	V _{CC} (V) (Note 8)	T _A = +25°C C _L = 50 pF		T _A = -40°C to +85°C C _L = 50 pF	Units
			Typ	Guaranteed Minimum		
t _S	Setup Time, HIGH or LOW	3.3	-1.0	1.5	1.5	ns
	D _n to CP	5.0	-1.0	1.5	1.5	
t _H	Hold Time, HIGH or LOW	3.3	-1.0	3.5	4.0	ns
	D _n to CP	5.0	-1.0	3.5	4.0	
t _W	CP Pulse Width	3.3	3.5	5.0	5.5	ns
	HIGH or LOW	5.0	2.5	4.0	4.0	

Note 8: Voltage Range 3.3 is 3.3V ± 0.3V
Voltage Range 5.0 is 5.0V ± 0.5V

AC Electrical Characteristics for ACT

Symbol	Parameter	V _{CC} (V) (Note 9)	T _A = +25°C C _L = 50 pF			T _A = -40°C to +85°C C _L = 50 pF		Units
			Min	Typ	Max	Min	Max	
f _{MAX}	Maximum Clock Frequency	5.0	120	150		110		MHz
t _{PLH}	Propagation Delay CP to O _n	5.0	2.0	6.0	9.5	1.5	10.5	ns
t _{PHL}	Propagation Delay CP to O _n	5.0	2.5	6.0	9.5	2.0	10.5	ns
t _{PZH}	Output Enable Time OE to O _n	5.0	2.5	7.0	10.5	2.0	11.5	ns
t _{PZL}	Output Enable Time OE to O _n	5.0	2.5	7.0	10.5	2.0	12.0	ns
t _{PHZ}	Output Disable Time OE to O _n	5.0	1.5	7.5	12.0	1.0	13.0	ns
t _{PLZ}	Output Disable Time OE to O _n	5.0	1.5	7.0	10.5	1.0	11.5	ns

Note 9: Voltage Range 5.0 is 5.0V ± 0.5V

AC Operating Requirements for ACT

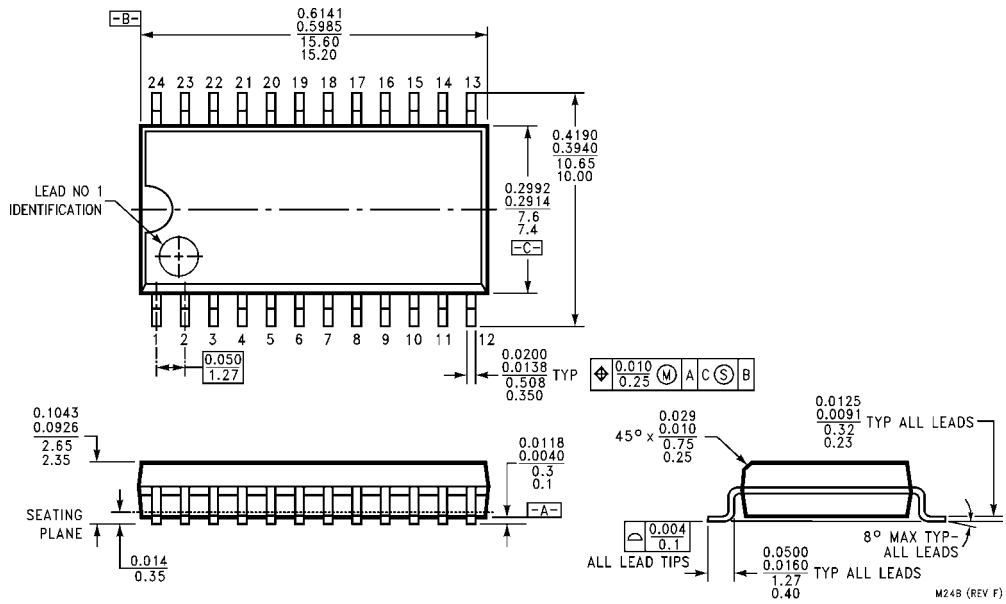
Symbol	Parameter	V _{CC} (V) (Note 10)	T _A = +25°C C _L = 50 pF		T _A = -40°C to +85°C C _L = 50 pF	Units
			Typ	Guaranteed Minimum		
t _S	Setup Time, HIGH or LOW D _n to CP	5.0	2.5	2.0	2.5	ns
t _H	Hold Time, HIGH or LOW D _n to CP	5.0	-0.5	2.0	2.5	ns
t _W	CP Pulse Width HIGH or LOW	5.0	3.0	4.5	5.5	ns

Note 10: Voltage Range 5.0 is 5.0V ± 0.5V

Capacitance

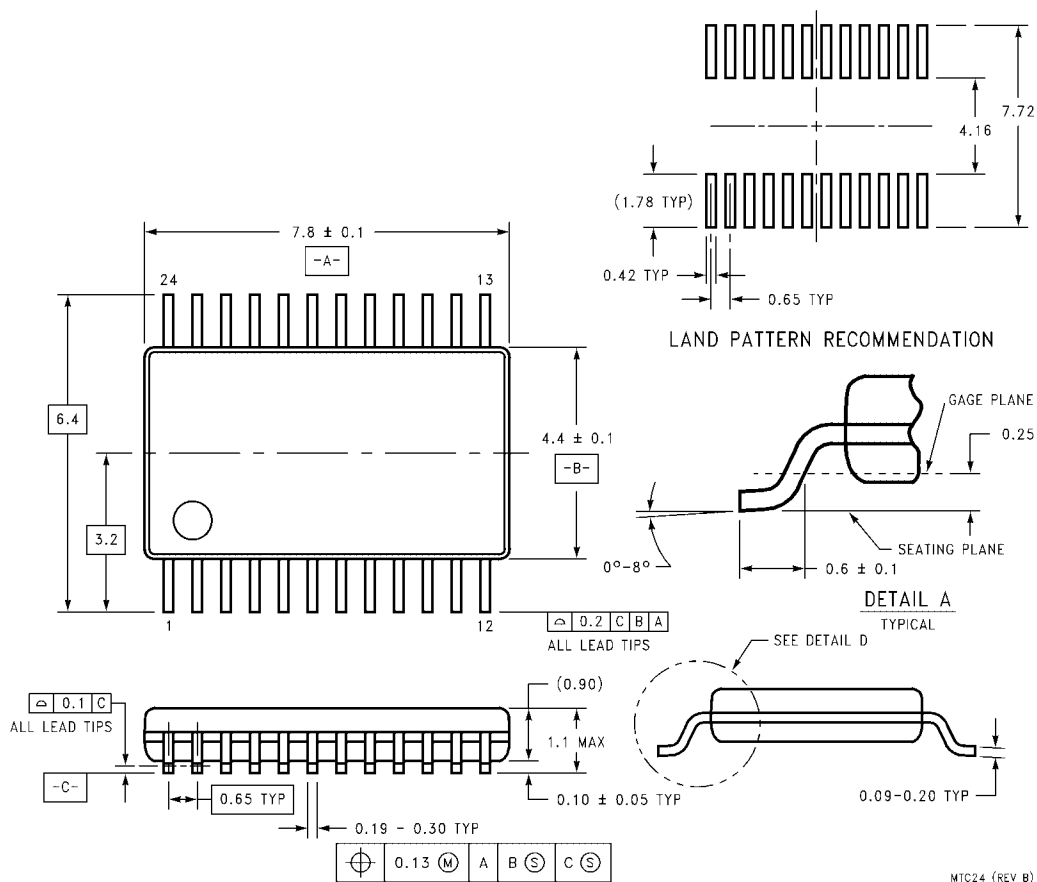
Symbol	Parameter	Typ	Units	Conditions
C _{IN}	Input Capacitance	4.5	pF	V _{CC} = OPEN
C _{PD}	Power Dissipation Capacitance	35.0	pF	V _{CC} = 5.0V

Physical Dimensions inches (millimeters) unless otherwise noted



24-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide
Package Number M24B

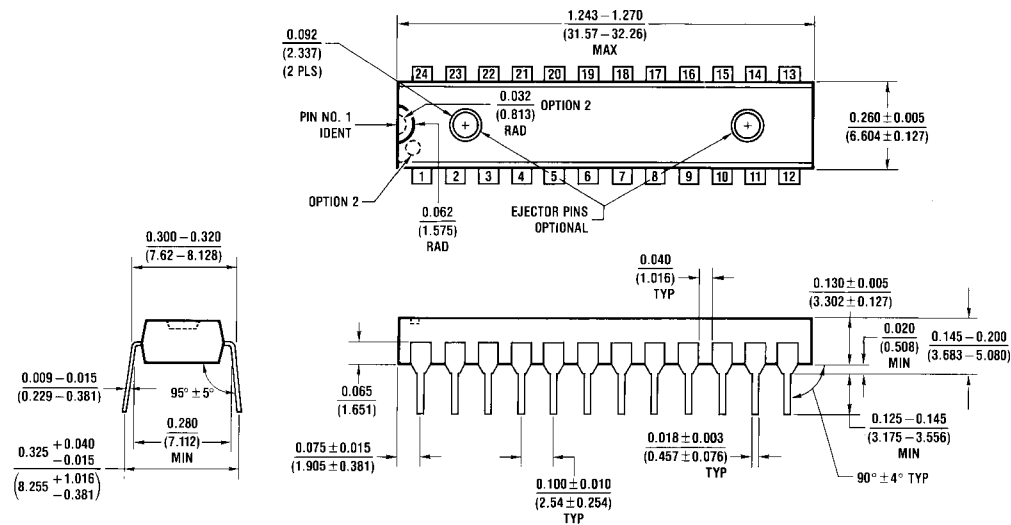
Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



24-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide
Package Number MTC24

MTC24 (REV B)

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



N24C (REV F)

24-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide
Package Number N24C

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